

Next Generation of Power Supplies

- Design for Manufacturability

Presented to

PEAC 2018

Nov 5-7, 2018

by

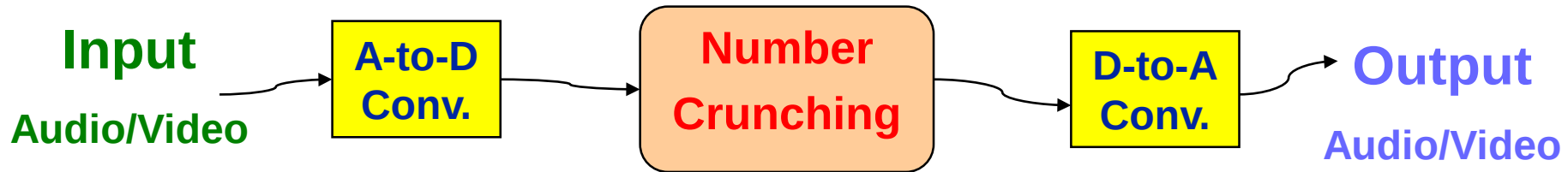
Fred C Lee

Virginia Tech

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Micro Electronics vs Power Electronics

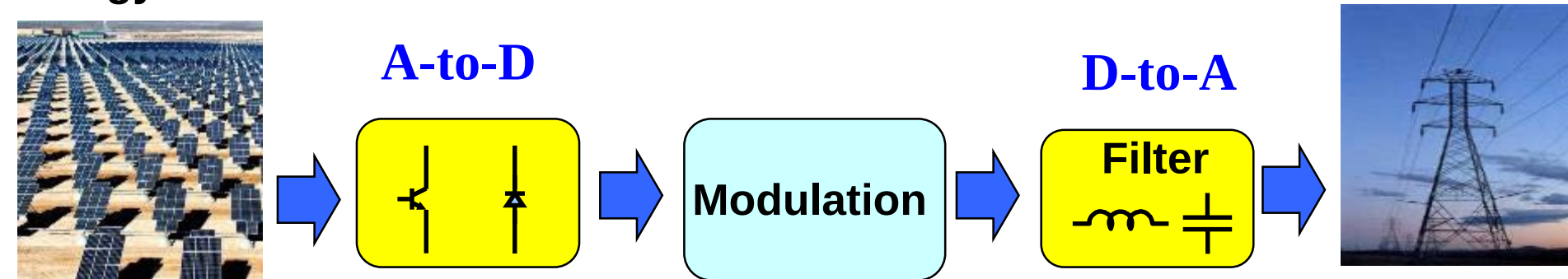
Micro Electronics Signal Processing



Power Electronics

Energy source

Energy source

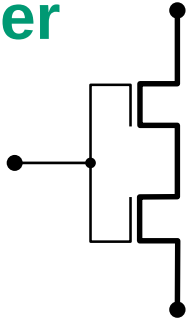


PV

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2 Building Blocks

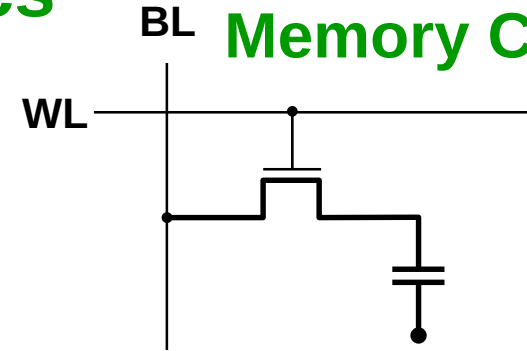
CMOS
Inverter



Micro Electronics

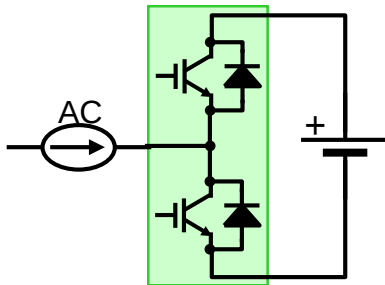
Building Blocks
(1V, mA)

DRAM
Memory Cell



Moore's Law prevails in 5 decades

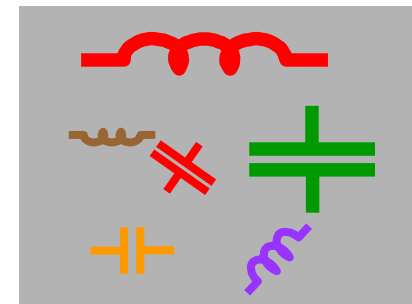
Power Cell
Inverter



Power Electronics

Building Blocks
(10V -1,000KV)
(1A-10,000A)

Energy Storage
Cell



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KPI: frequency, efficiency & power density

Evolution of Power Devices

BI-POLAR
(60-70)



10X

Switching
Frequency

Efficiency

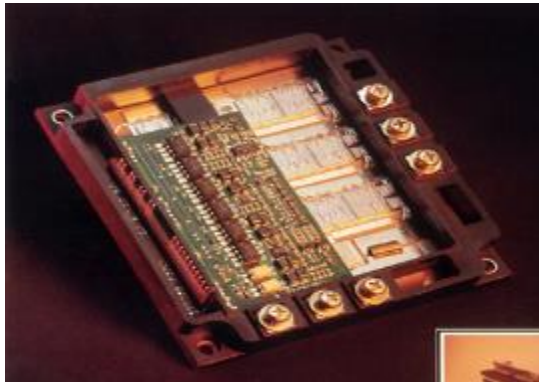
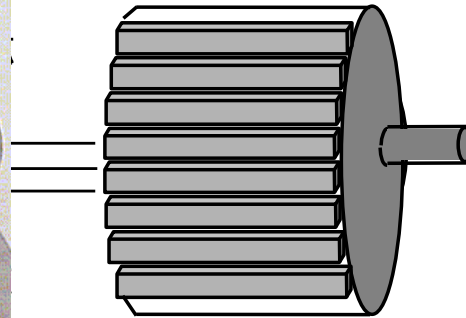
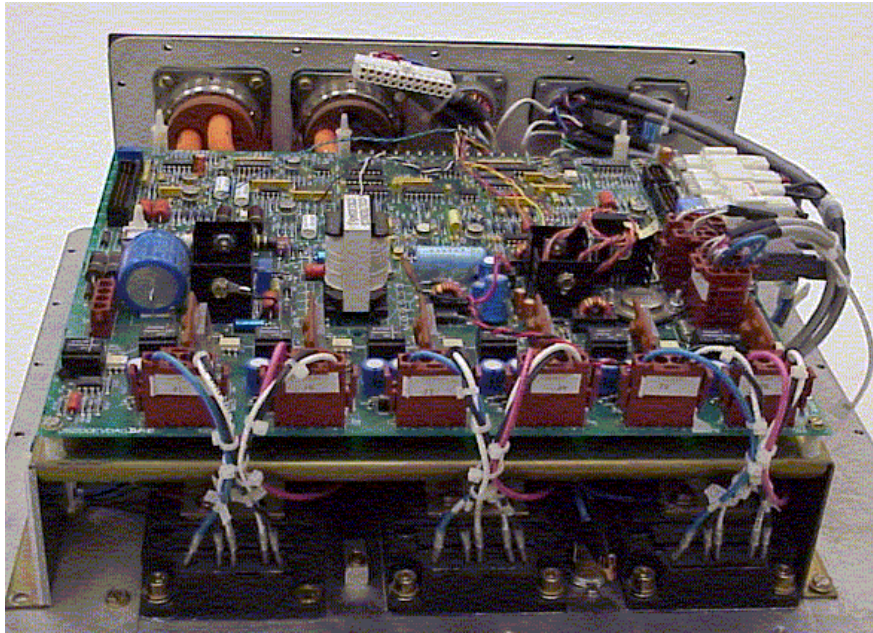
Power Density

MOSFET/IGBT
(80- present)

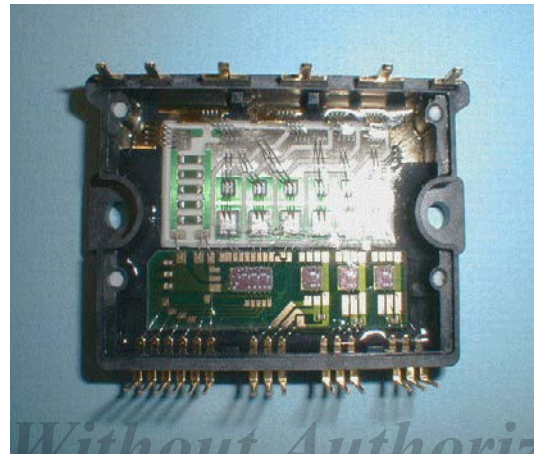


int With

Power Module Integration



Toshiba



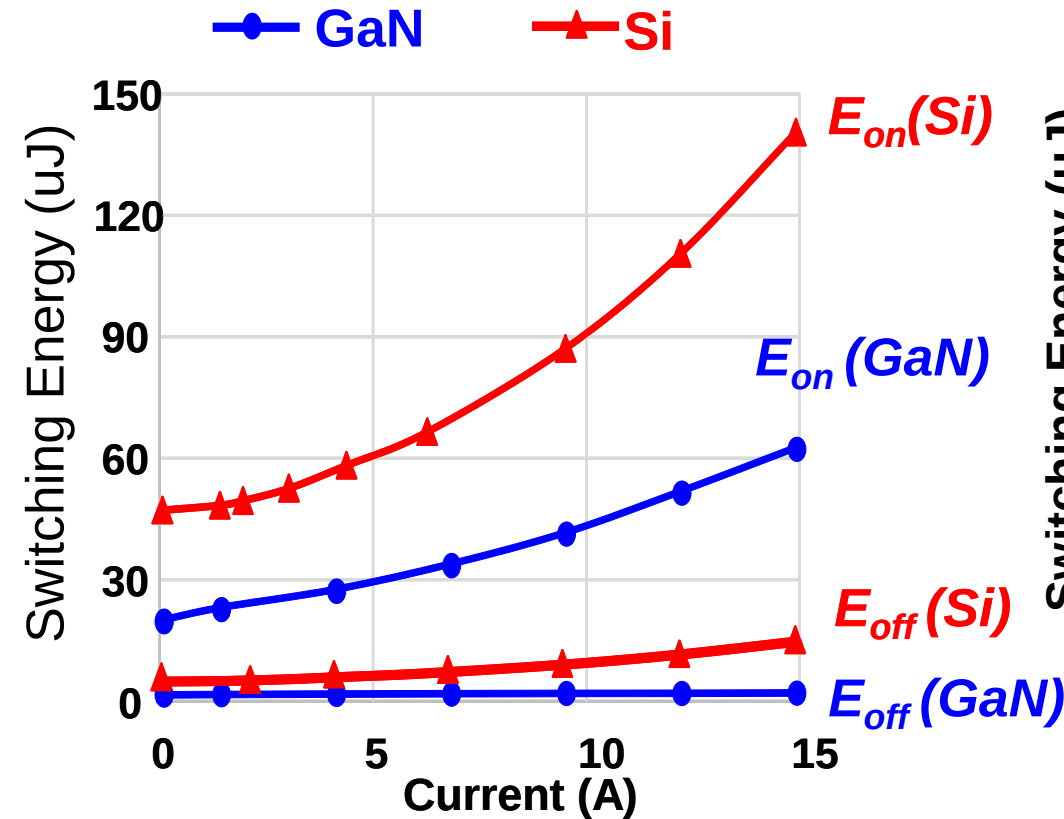
Fuji

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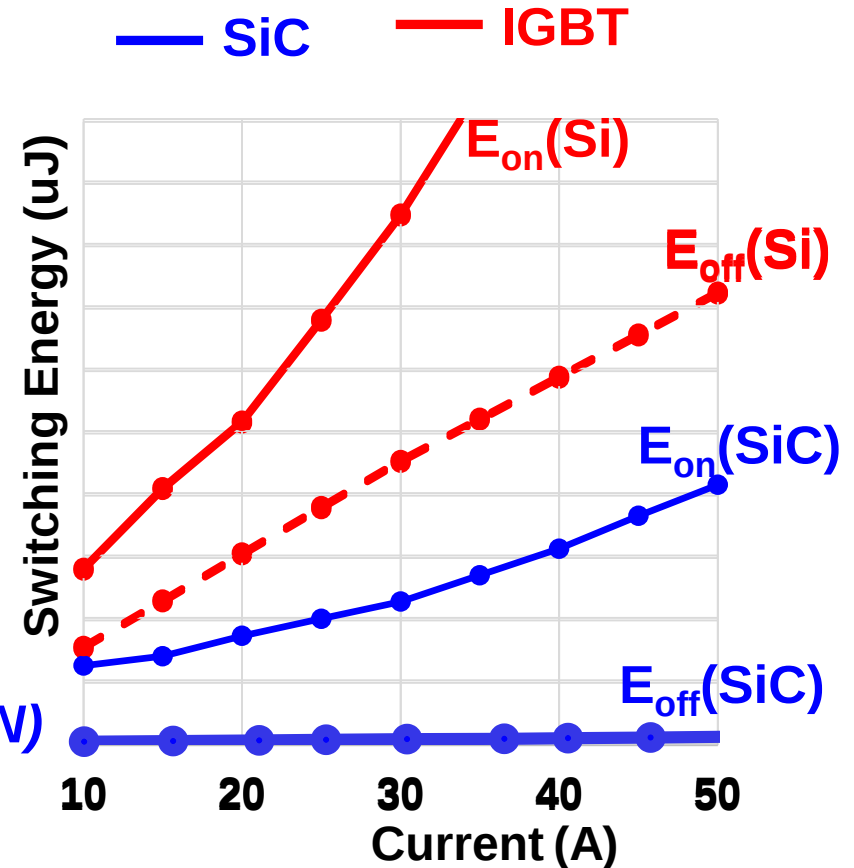
Switching Loss Comparison

WBG and Silicon

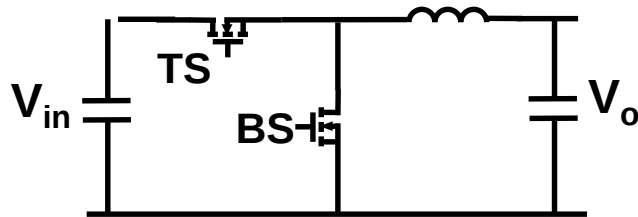
GaN v.s. Silicon (MOSFET)



SiC v.s. Silicon (IGBT)

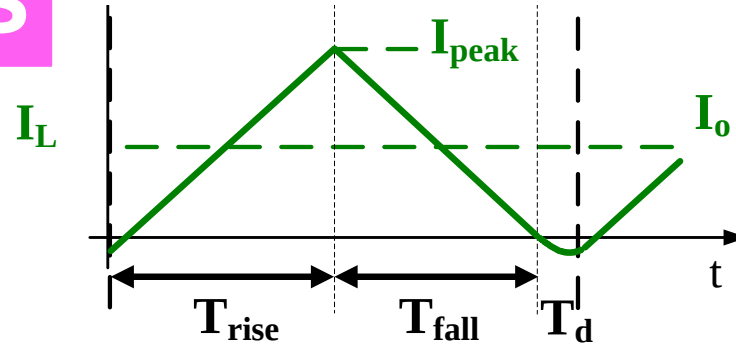


GaN: Loss Breakdown



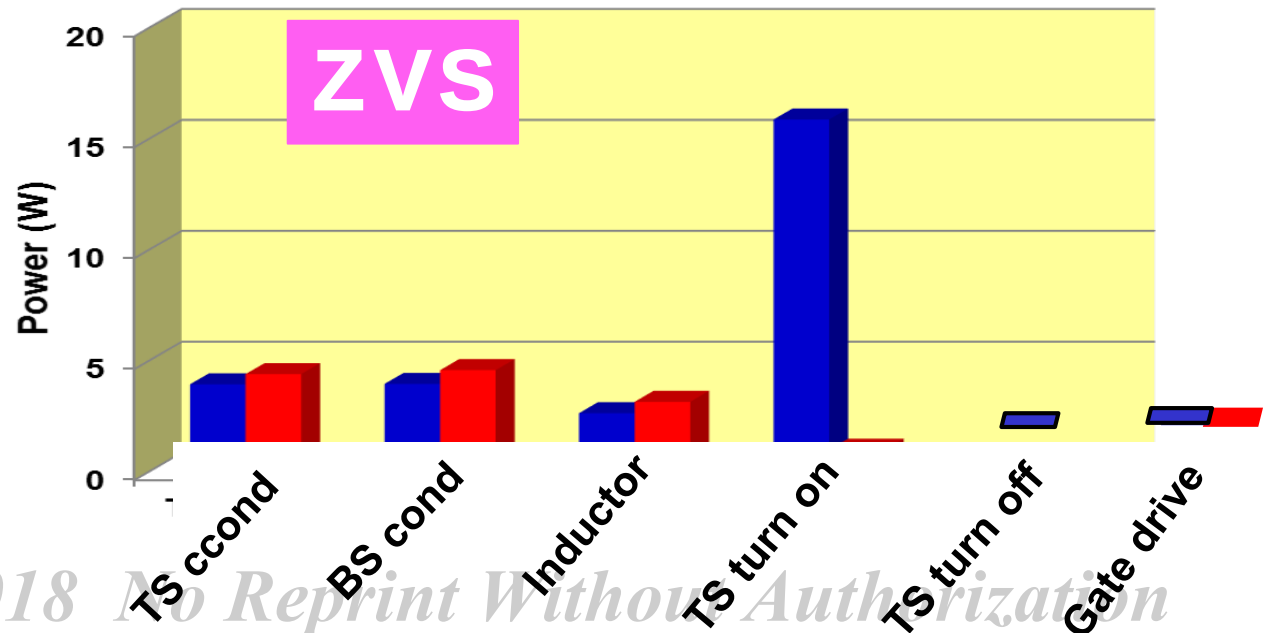
1.2 KW @ 1MHz

ZVS



Loss Breakdown @ 1.2kW

Switching losses
are negligible



What Do You Do?

If you are given a device without switching losses,
what would you do ?

“Figure of Metrics ”
Is it a meaningful metrics ?

Shall we re-assess our design approach
and trade off criteria ?

Challenges for WBG

Low threshold voltage & breakdown voltage

dv/dt (>6X)

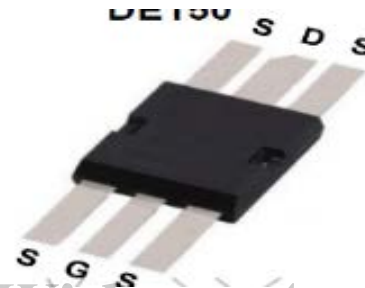
di/dt (>3X)

Packaging consideration

TO220

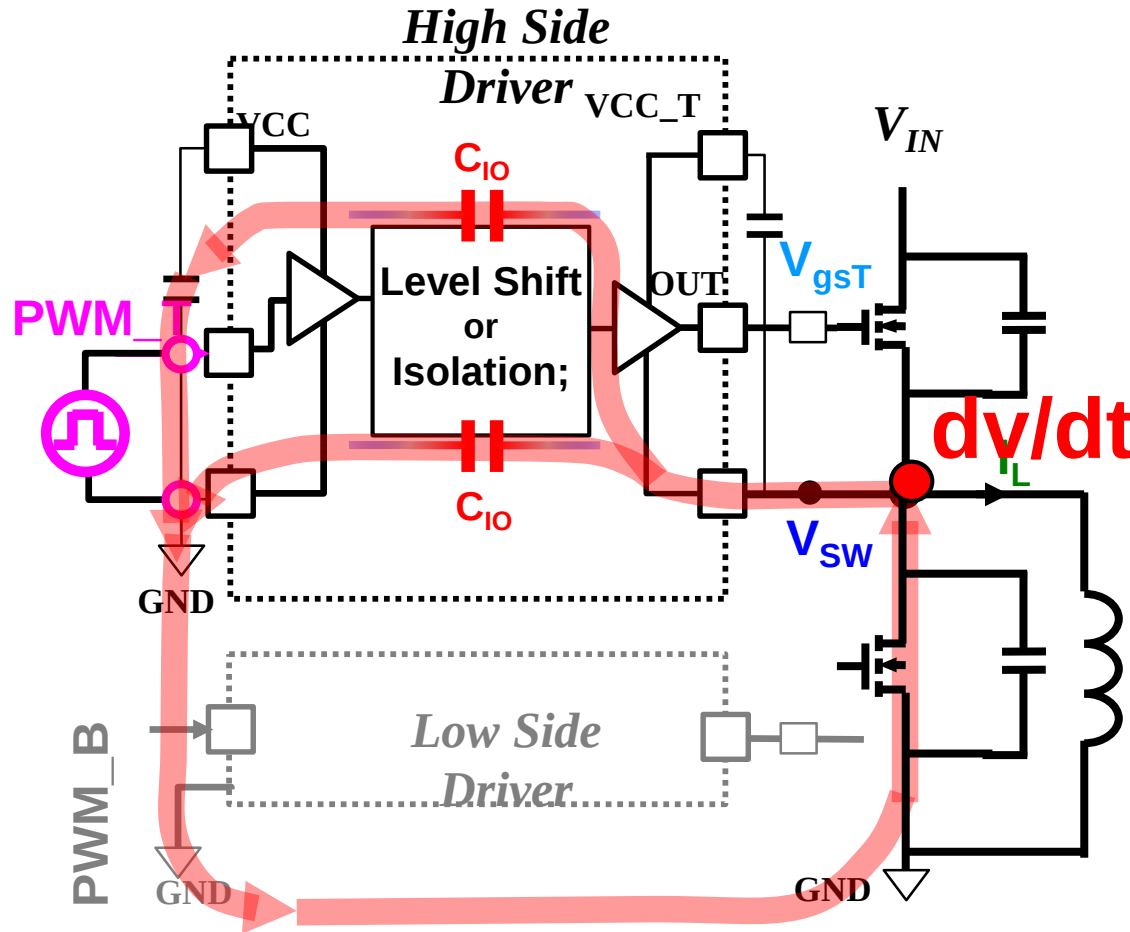


GAN/SiC

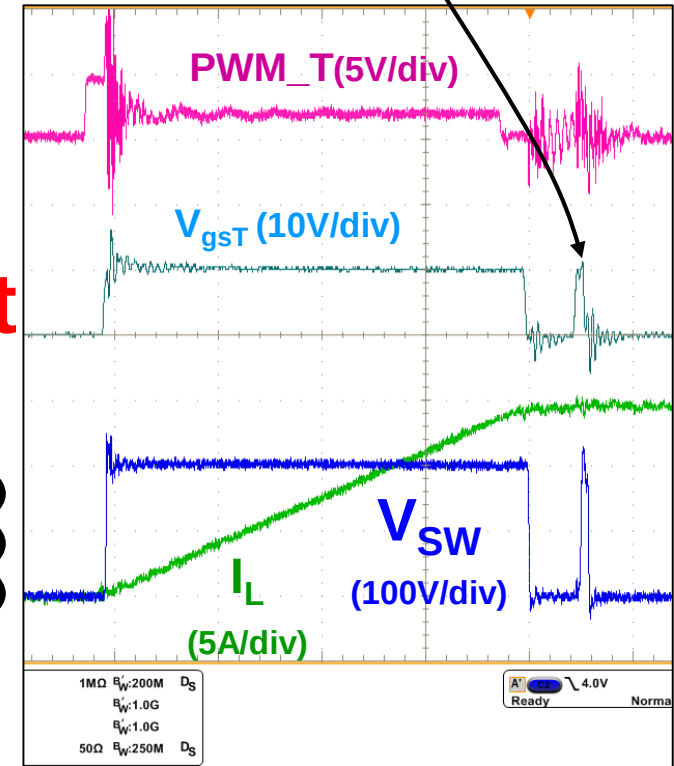


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dv/dt Deteriorates Input PWM Signal



Fault trigger



- High dv/dt noise deteriorates the input PWM signal

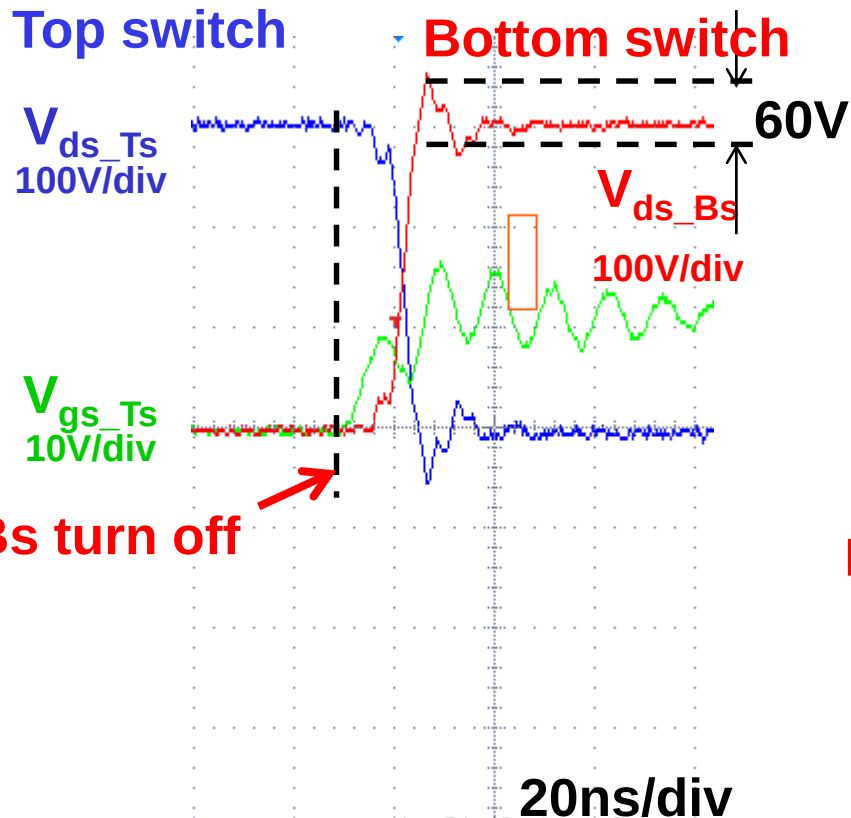
IEEE TRANSACTIONS ON POWER ELECTRONICS, 2018, No. Reprints Without Authorization

Soft v.s. Hard Switching

During Turn On

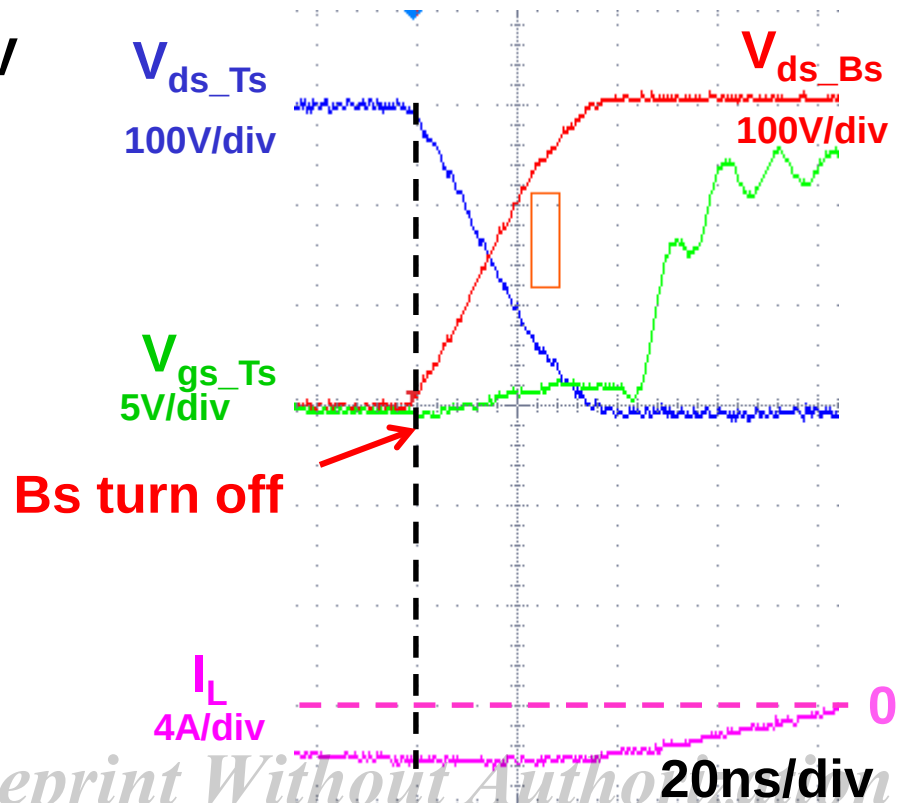
Hard Switching

CCM: $L = 250\mu\text{H}$, $\Delta I_{LL} = 0.4\text{A}$



Soft Switching

CRM: $L = 6\mu\text{H}$, $\Delta I_{LL} = 14\text{A}$



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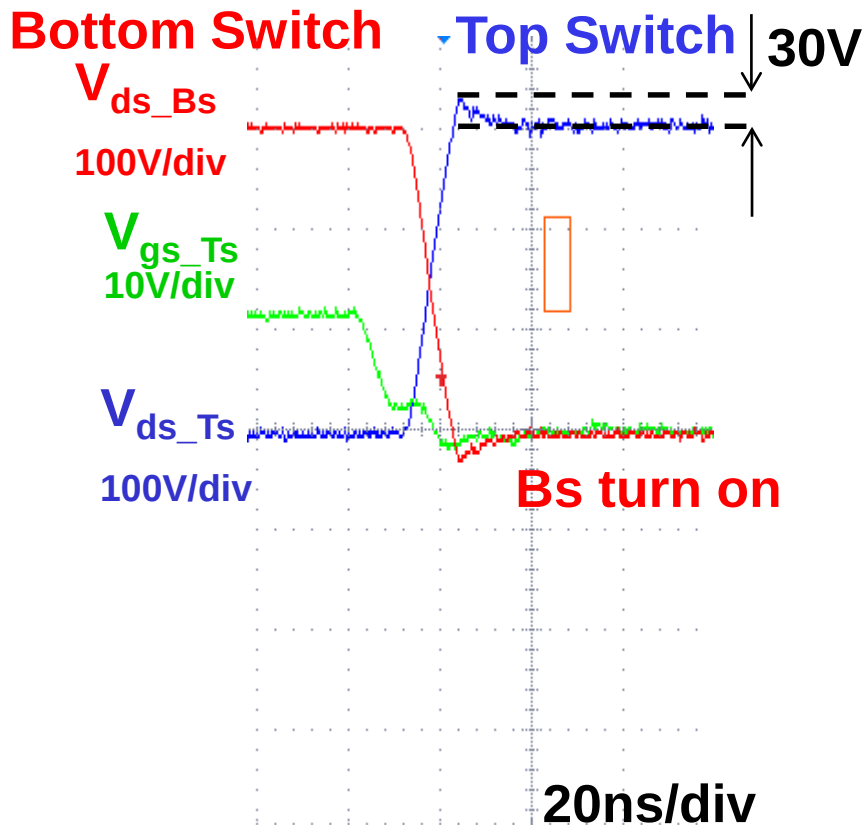
$F = 500\text{kHz}$, $V_{in} = 300\text{V}$, $V_{out} = 48\text{V}$, $I_{out} = 5\text{A}$

Soft v.s. Hard Switching

During Turn Off

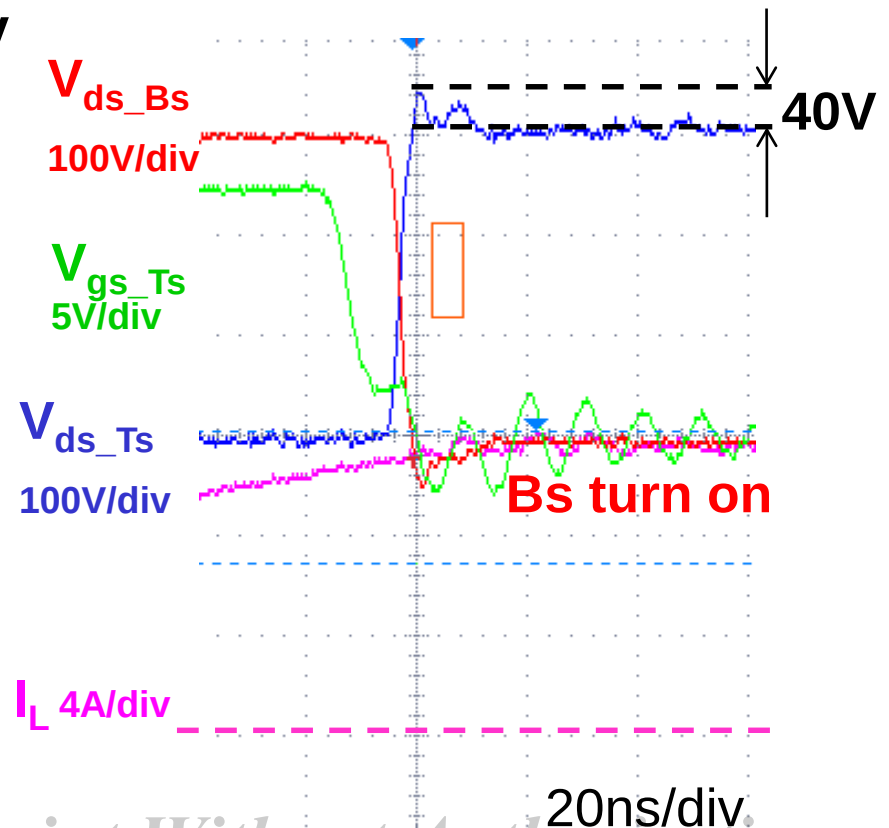
Hard Switching

CCM: $L=250\mu\text{H}$, $\Delta I_{LL}=0.4\text{A}$



Soft Switching

CRM: $L=6\mu\text{H}$, $\Delta I_{LL}=14\text{A}$



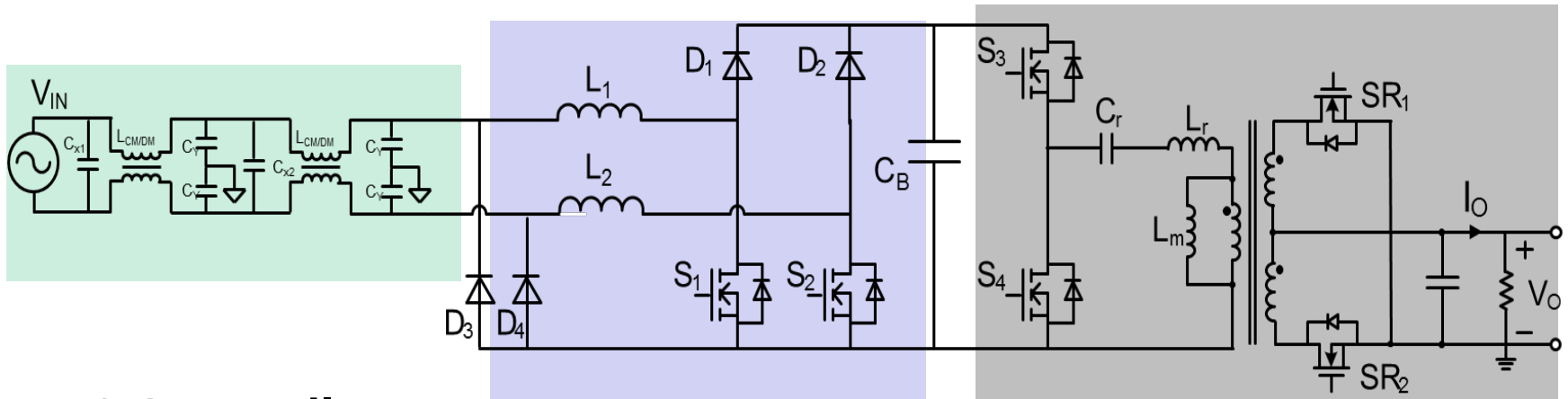
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F=500kHz, $V_{in}=300\text{V}$, $V_{out}=48\text{V}$, $I_{out}=5\text{A}$

Demonstrations

- 1. Server power supplies (1 KW)**
- 2. EV chargers (6.6 KW)**

Today's Server Power Supply



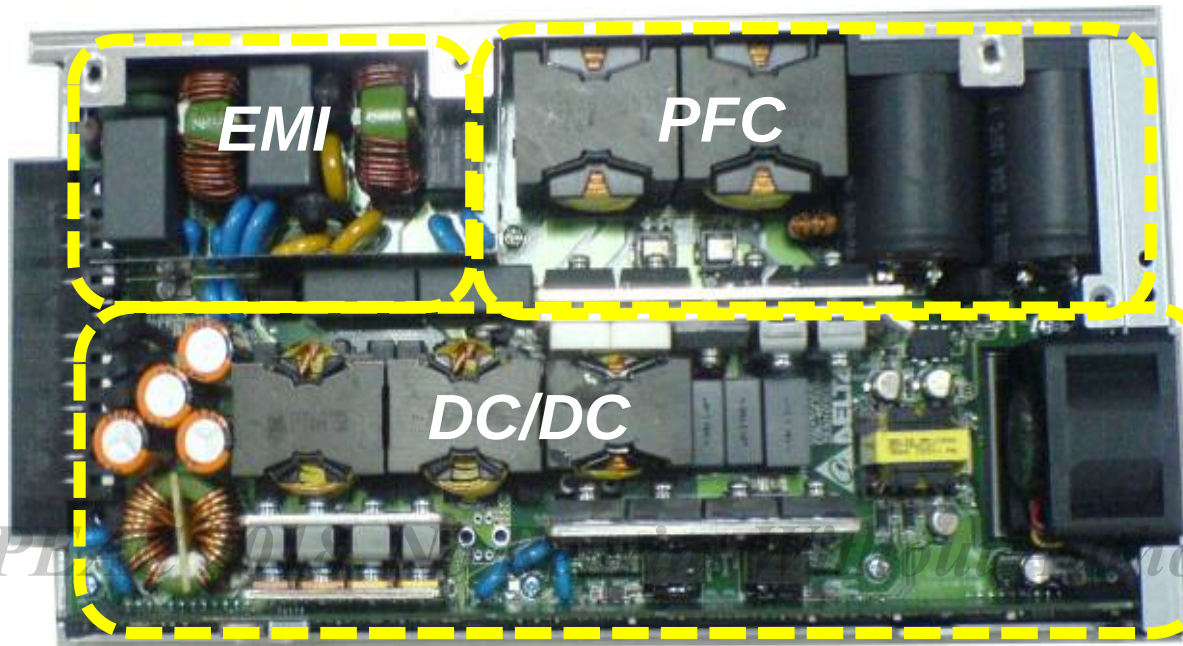
2-Stage Filter

Bridgeless PFC

100KHz

LLC DC/DC

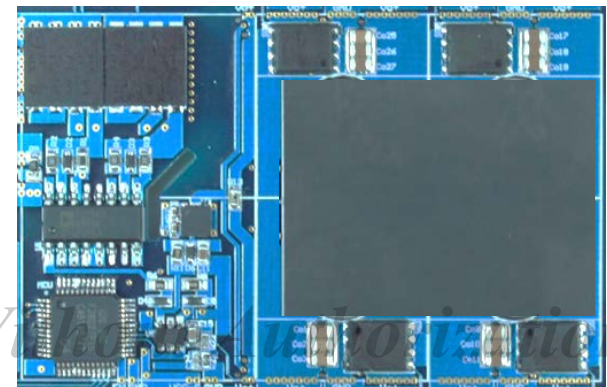
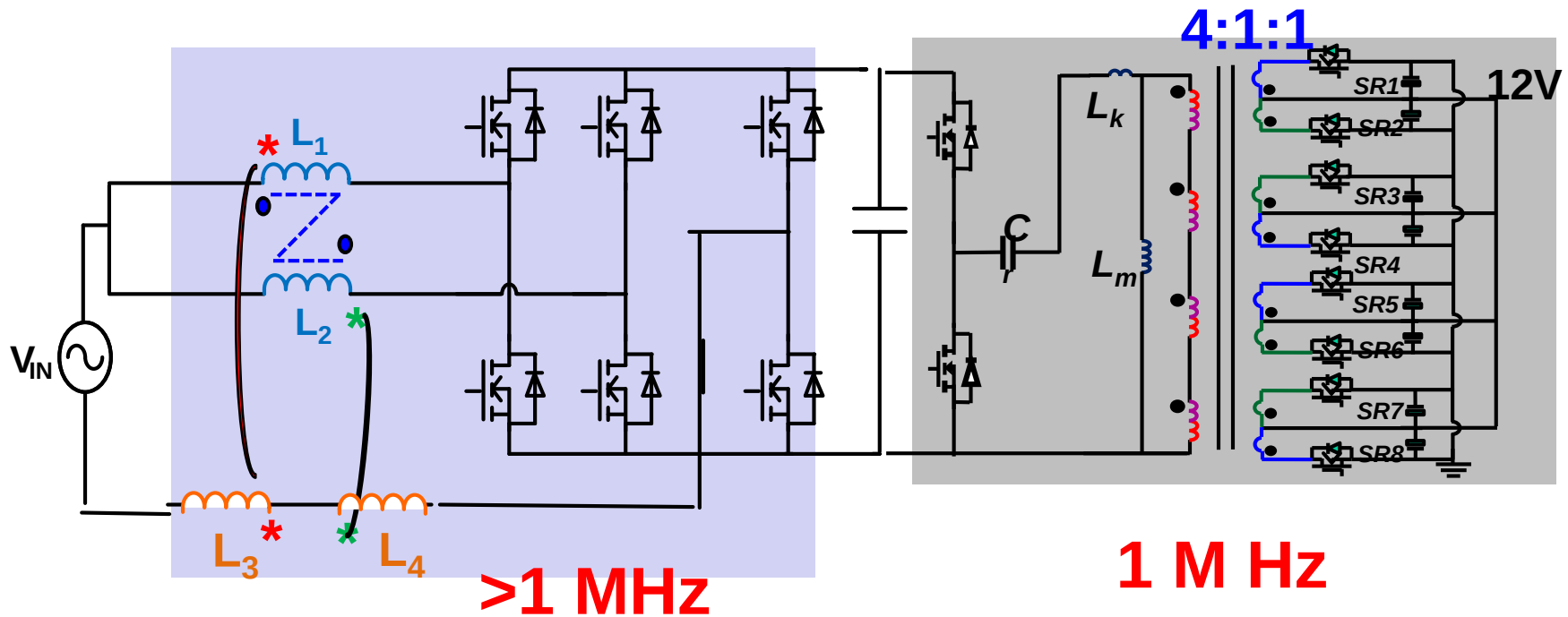
100-200 KHz



96%
30-40 W/in³

IEEE P92.1-2011 Standard for 100W Server Power Supply

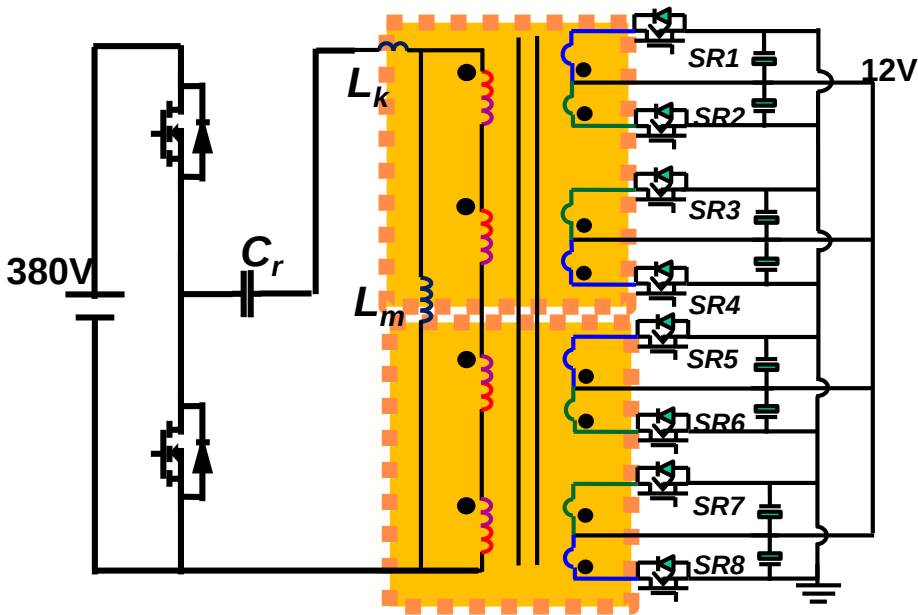
GaN Based Server Power supplies



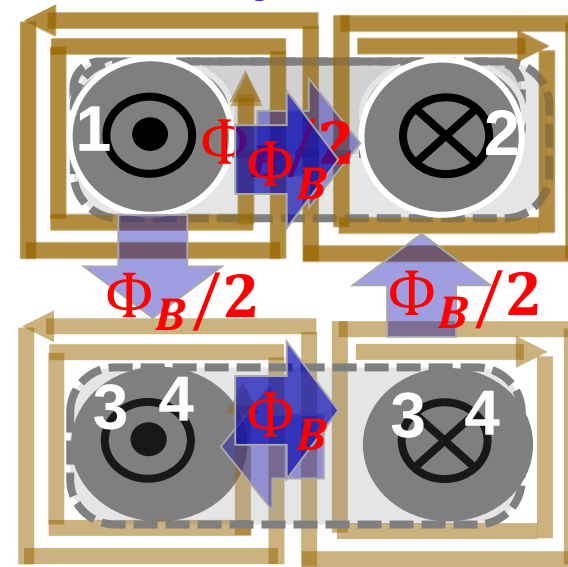
1MHz LLC Converter

1MHz, 800W

4:1:1



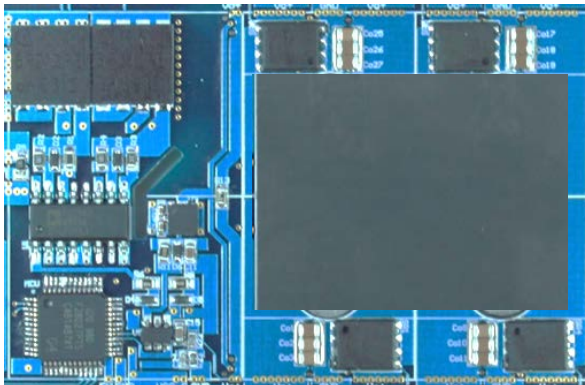
4-layer PCB



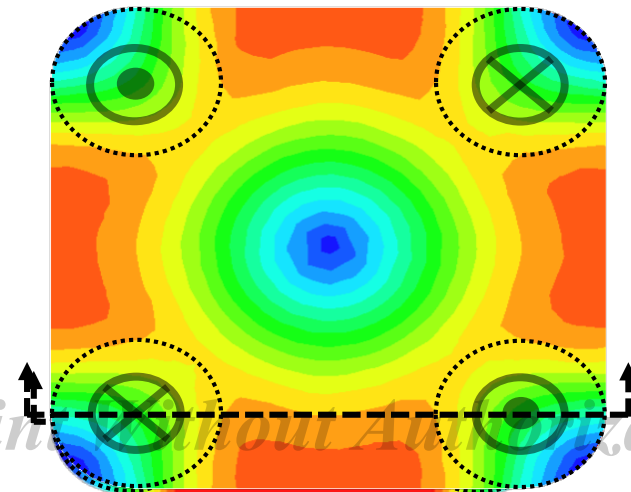
Core1

Core2

Flux Distribution



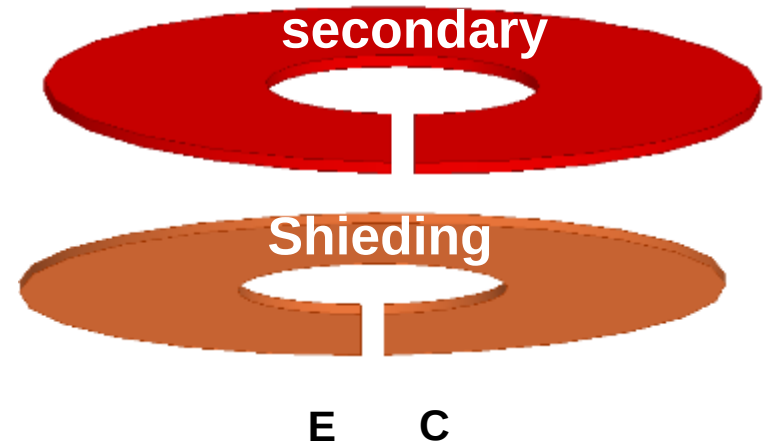
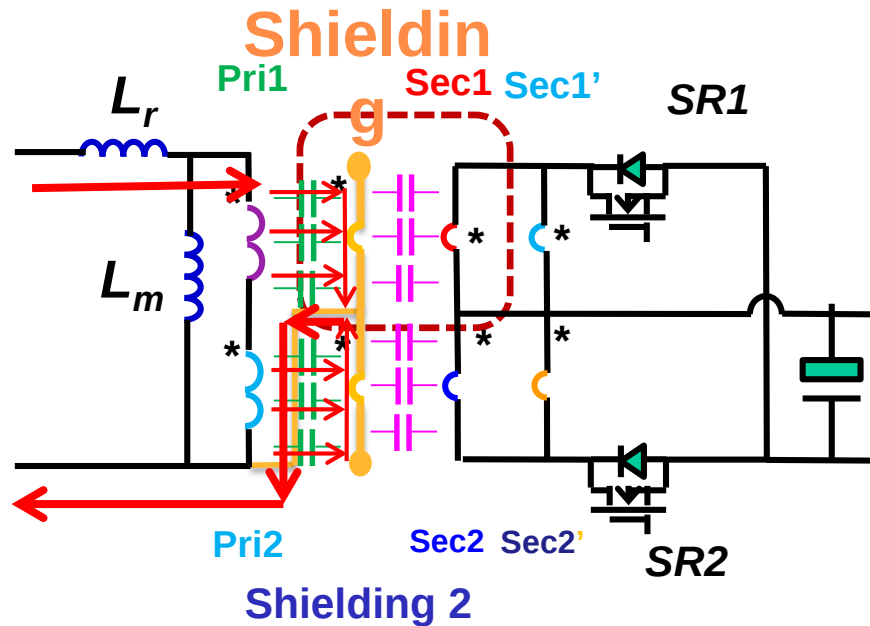
900W/in³ @ 97.6%



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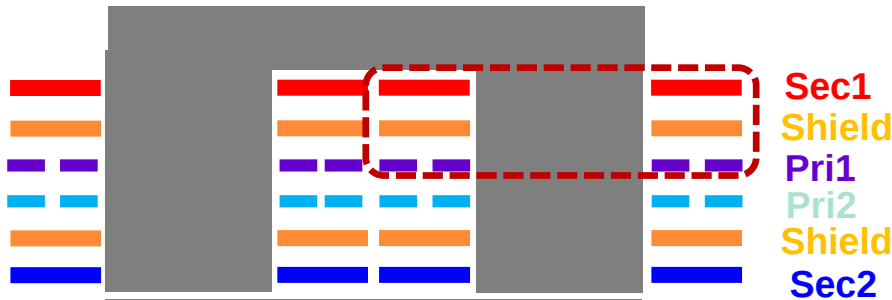
Shielding for CM Noise Reduction

US patent

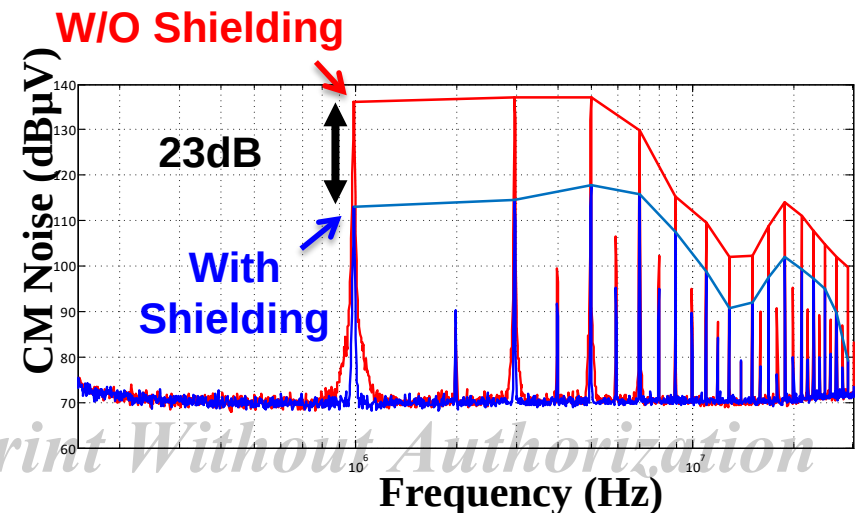


No displacement current

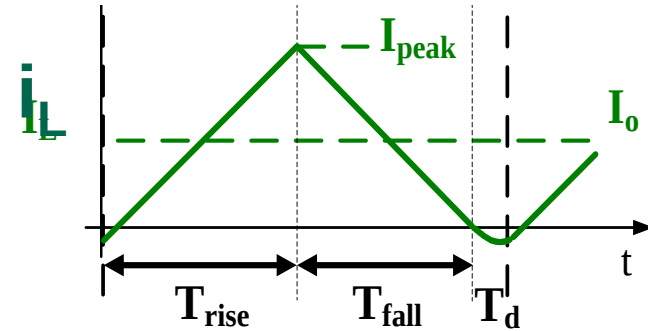
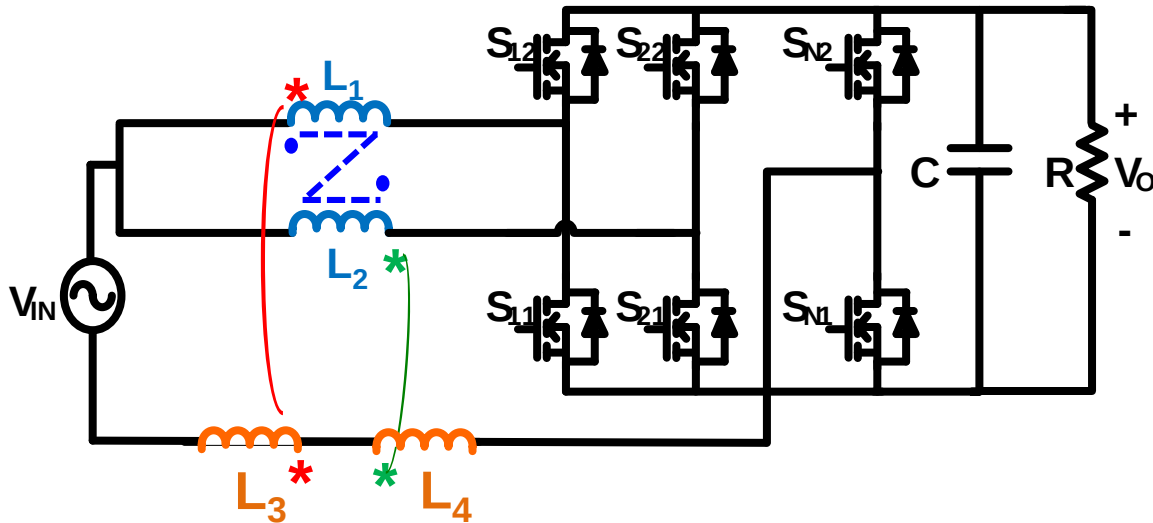
4:1:1



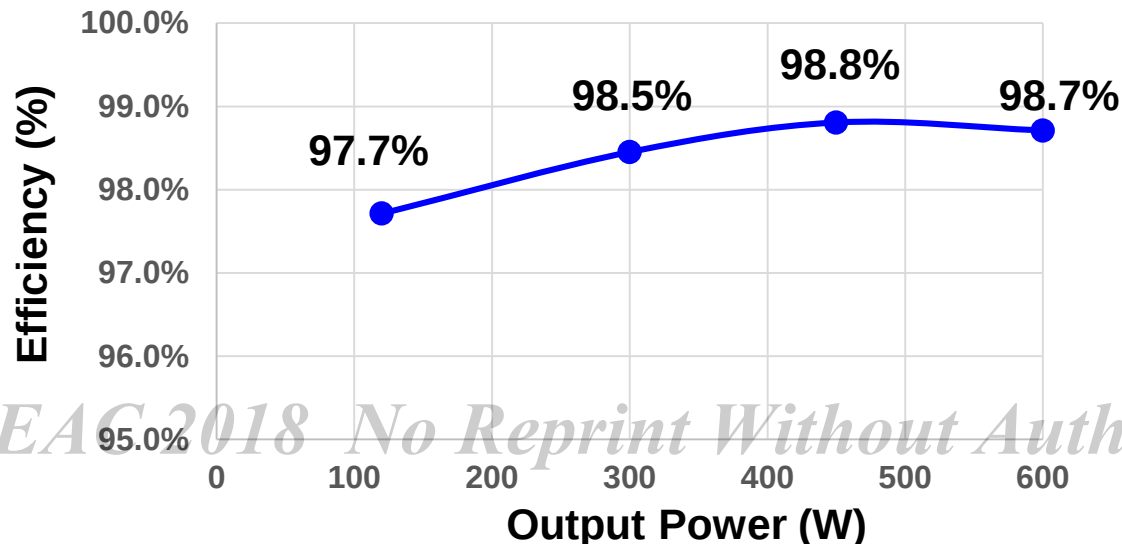
6 layers PCB



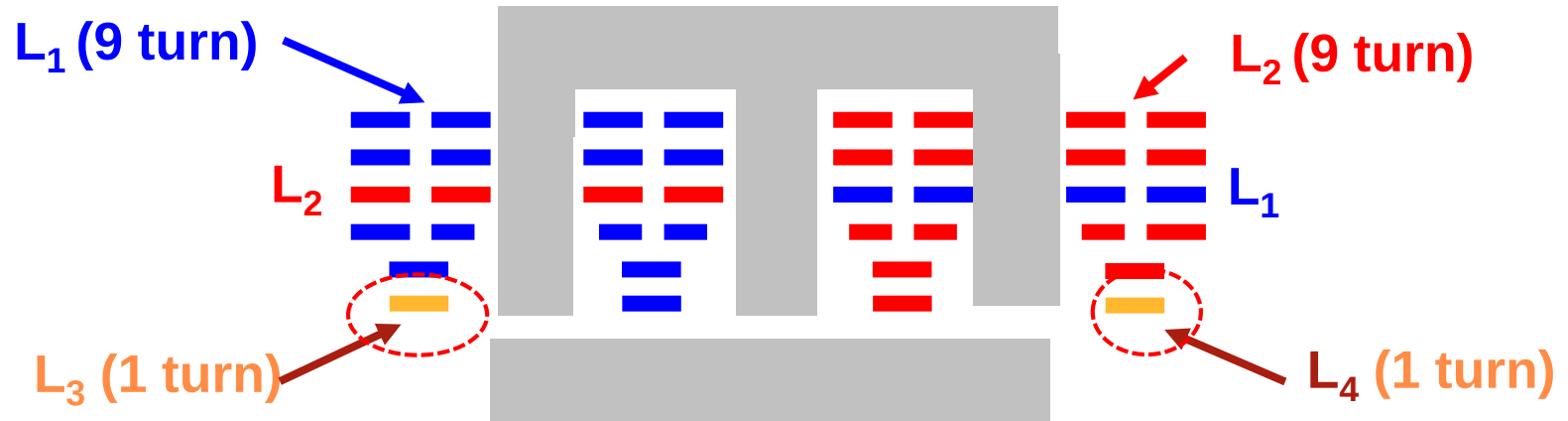
1-3 MHz, 1KW PFC



Balance Technique: L_3 & L_4 for CM reduction

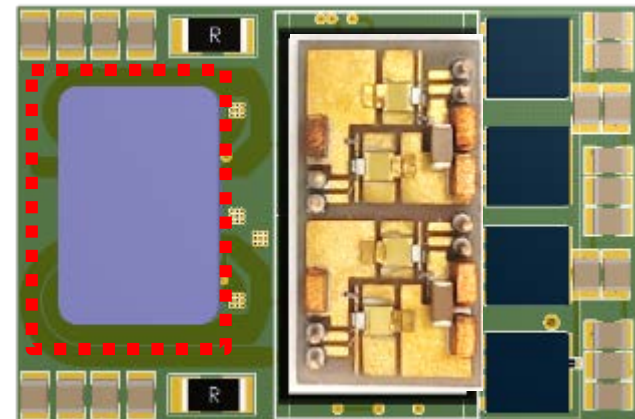
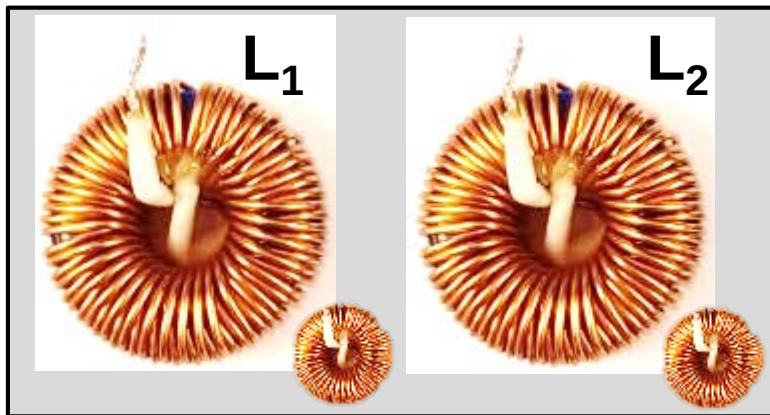


“Balance” for CM Noise Reduction



6 layer PCB

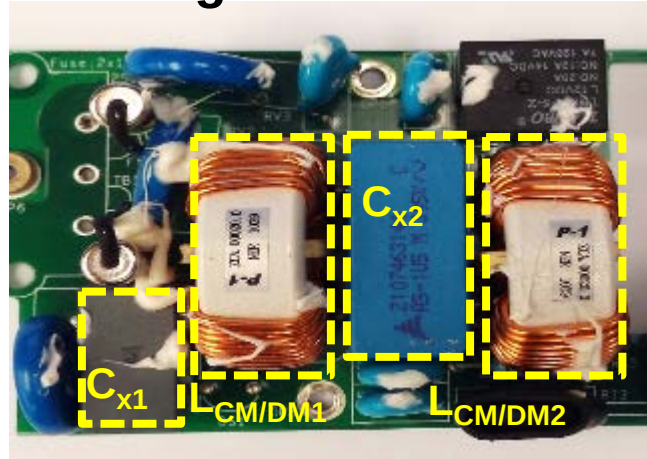
700W/in³ (without cap)



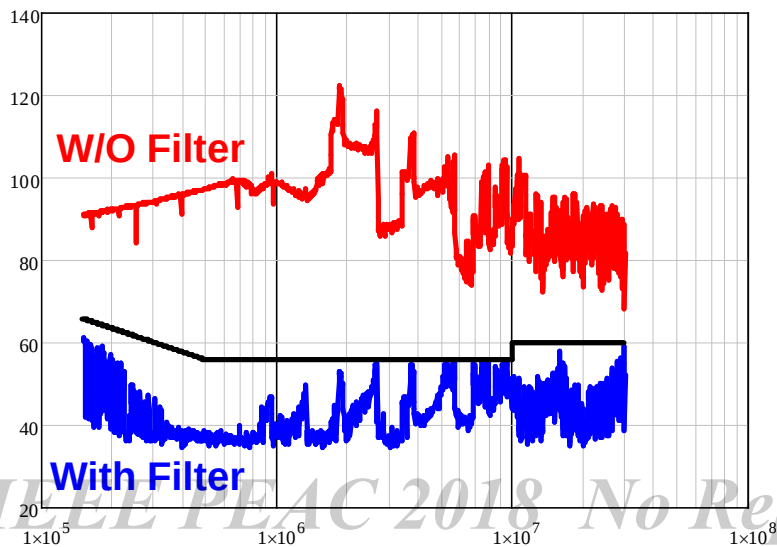
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Inductor Integration

2-Stage EMI Filter



DM Noise

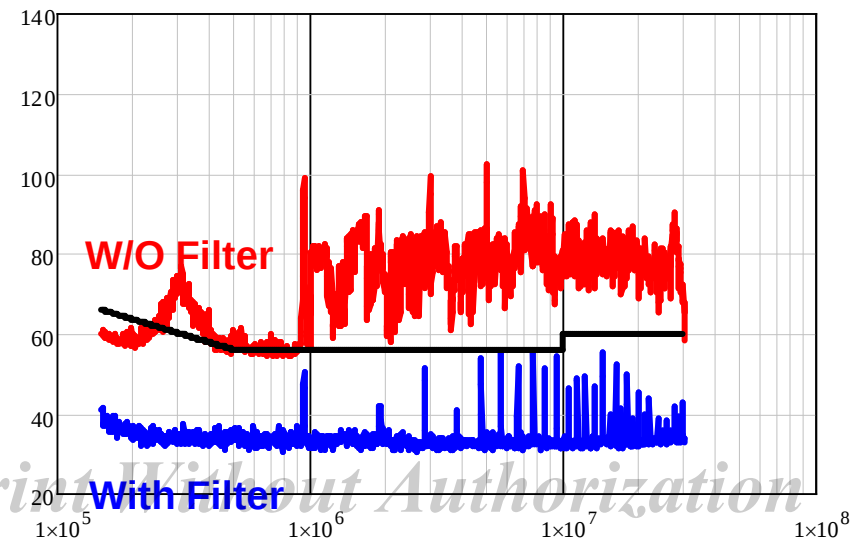


Single-Stage EMI Filter



75% volume reduction

CM Noise



Manufacture Paradigm

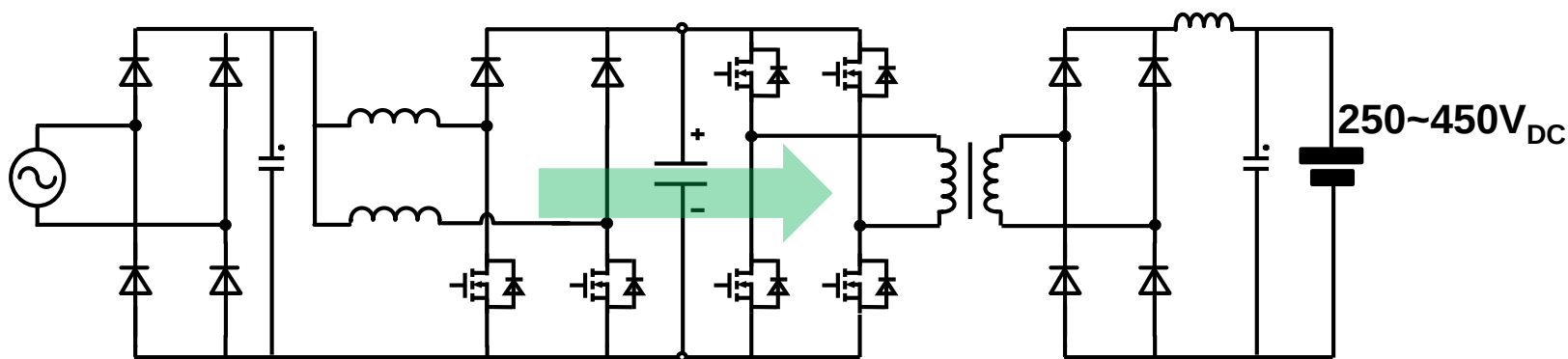
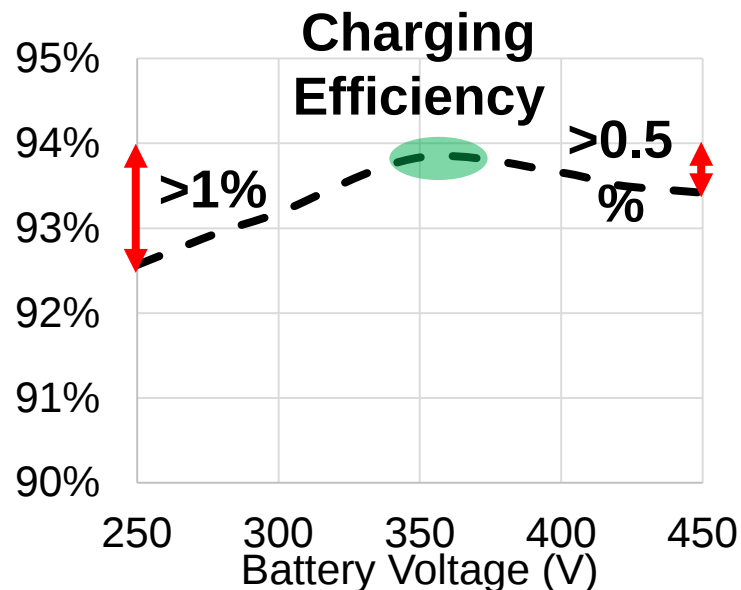


Automated Manufacturing

Conventional On-Board Charger



6.8KW Bidirectional OBCI



Dual Boost PFC (CCM)

20-50kHz 96% peak eff.

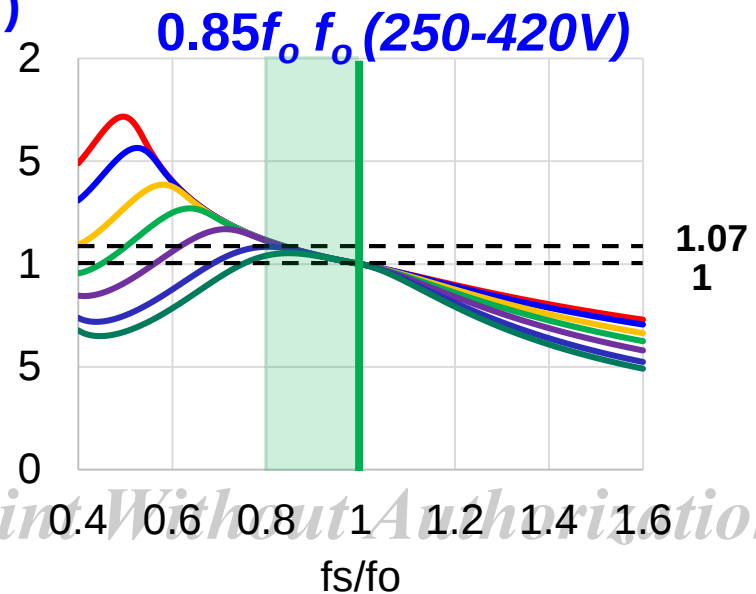
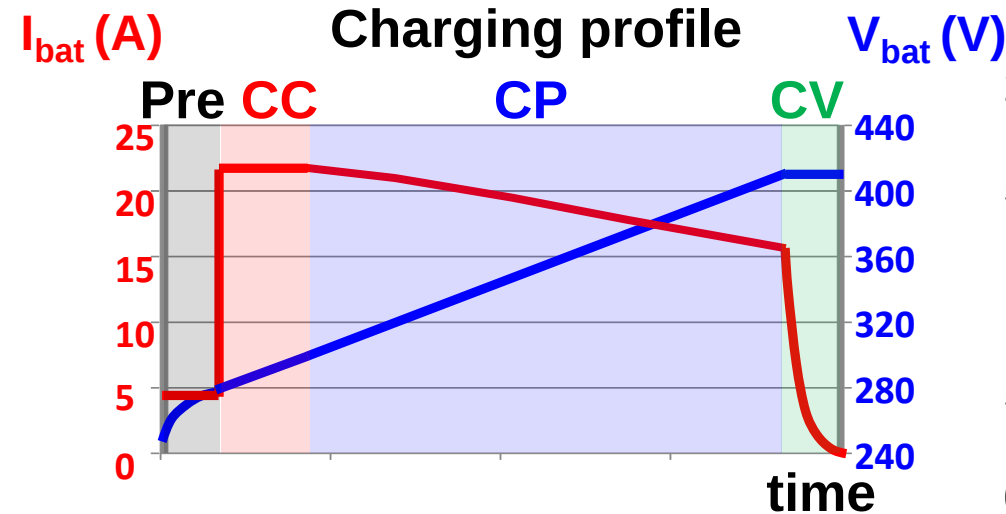
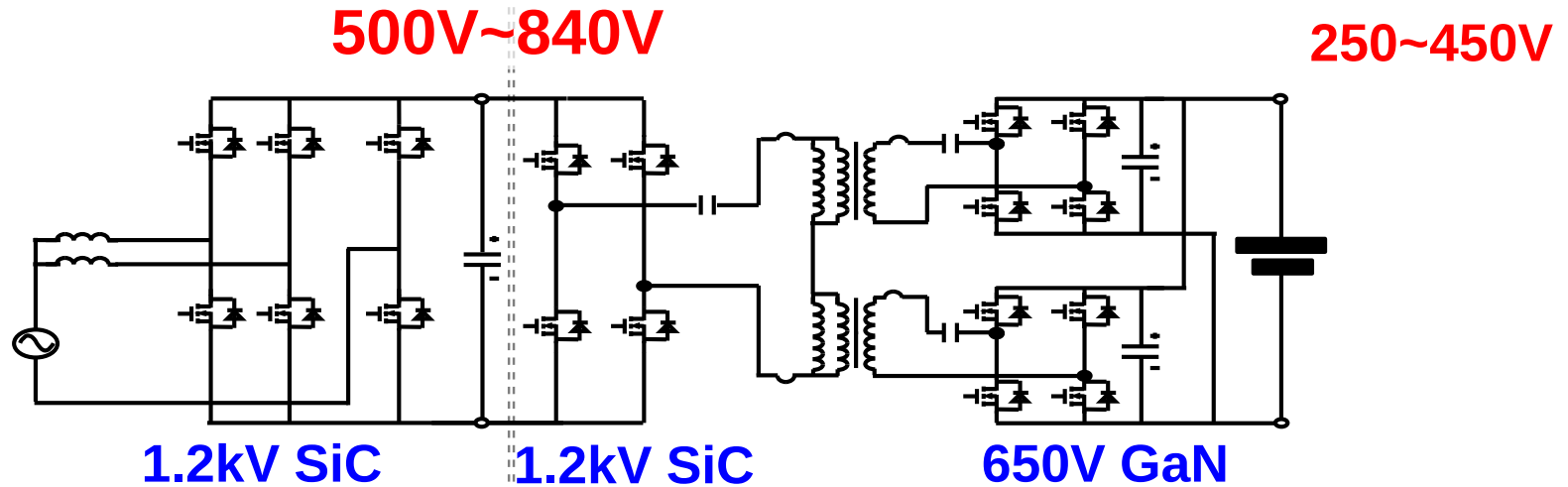
Phase Shift Full Bridge

20-50kHz 96% peak eff.

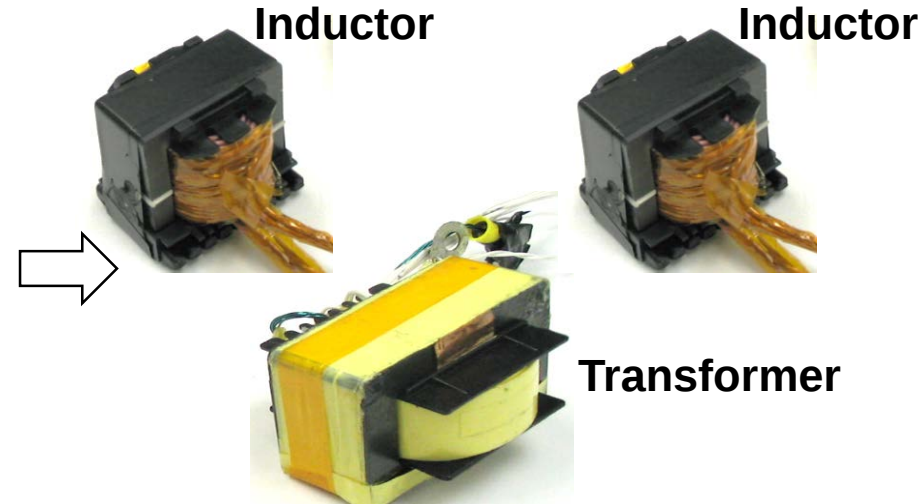
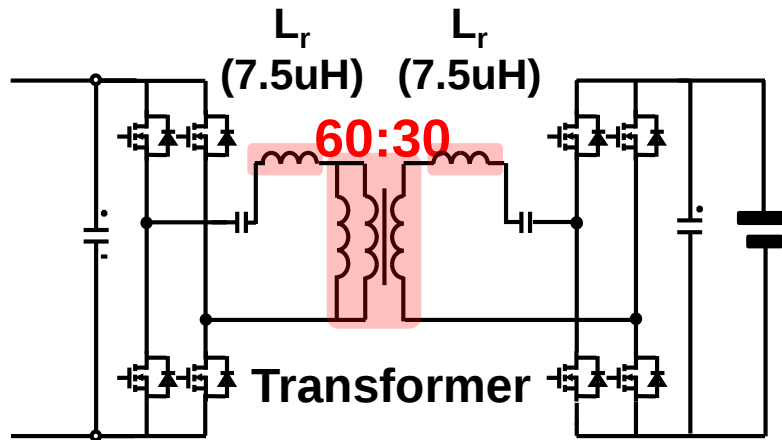
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Proposed On-Board Charger

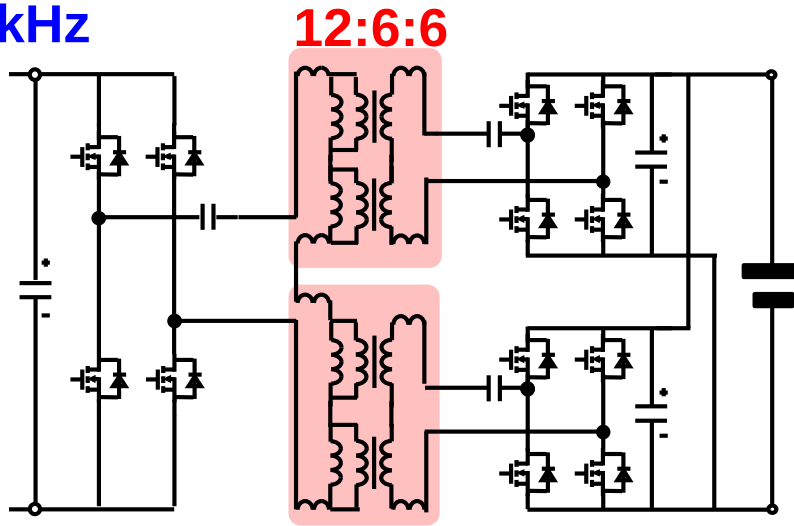
Proposed Design: **Variable DC-Link Voltage**



PCB Based Magnetic Integration

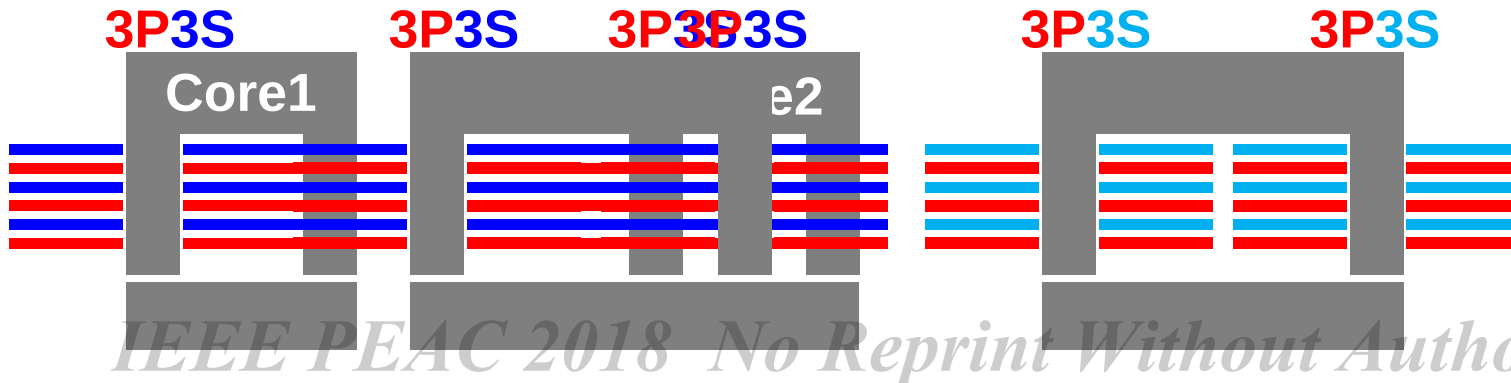
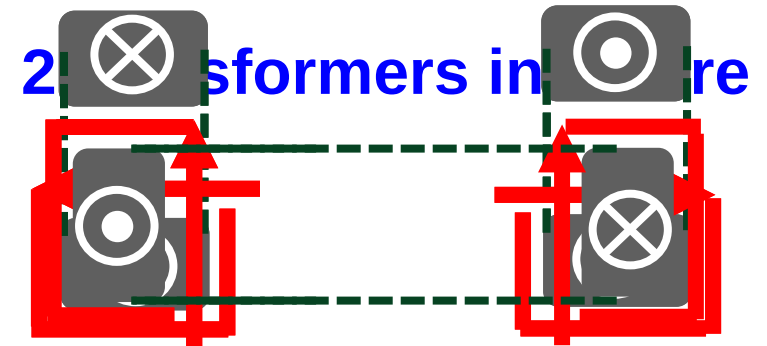
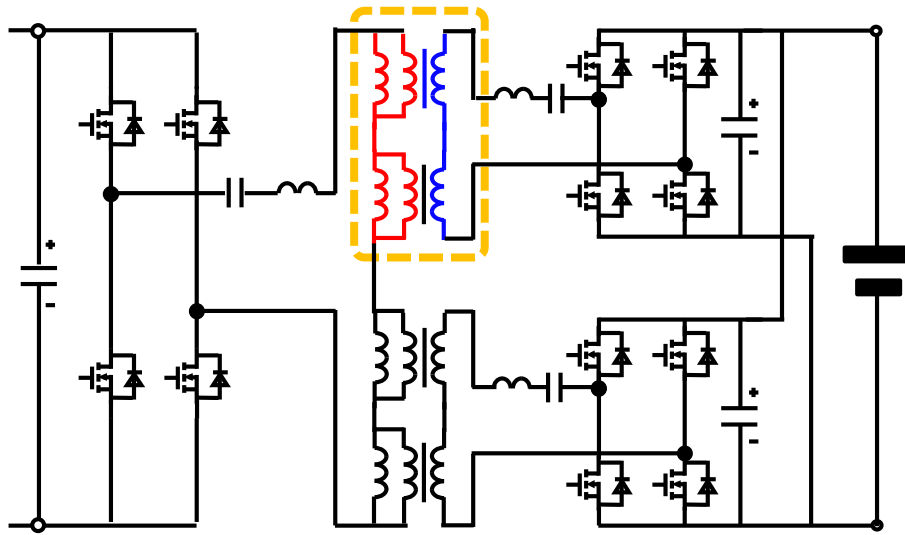


500kHz



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Transformer + L_r (1.5uH)

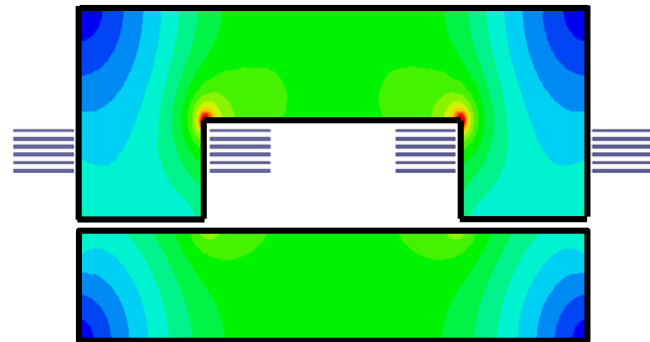
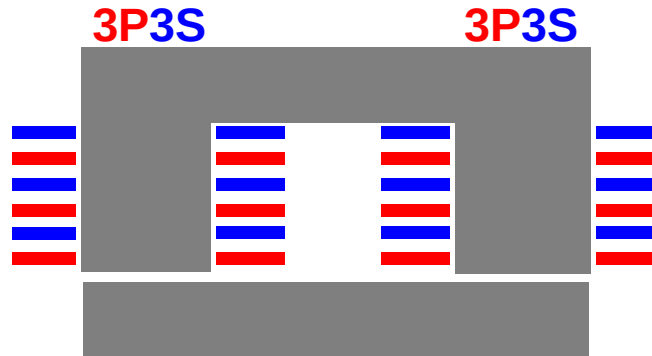
Magnetic Integration w/ Flux Cancellation



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Built-in Leakage Inductors

UI Core

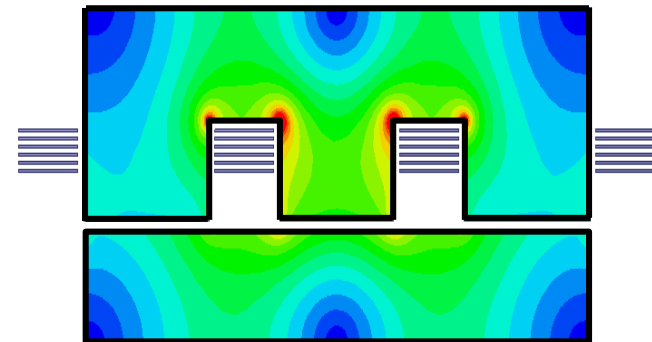
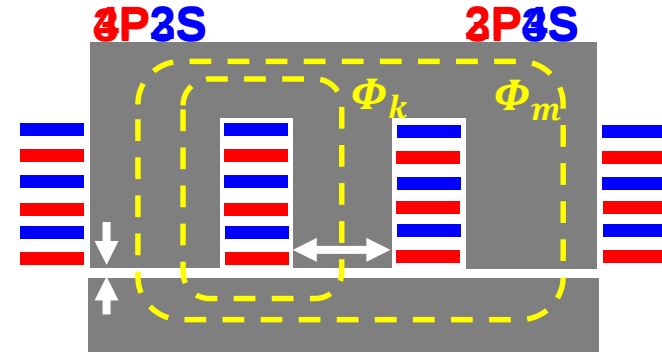


$$L_m = 17\mu\text{H}$$

$$L_r = 103\text{nH} \ll 1.4\mu\text{H}$$

Leakage inductance is too small
to be useful

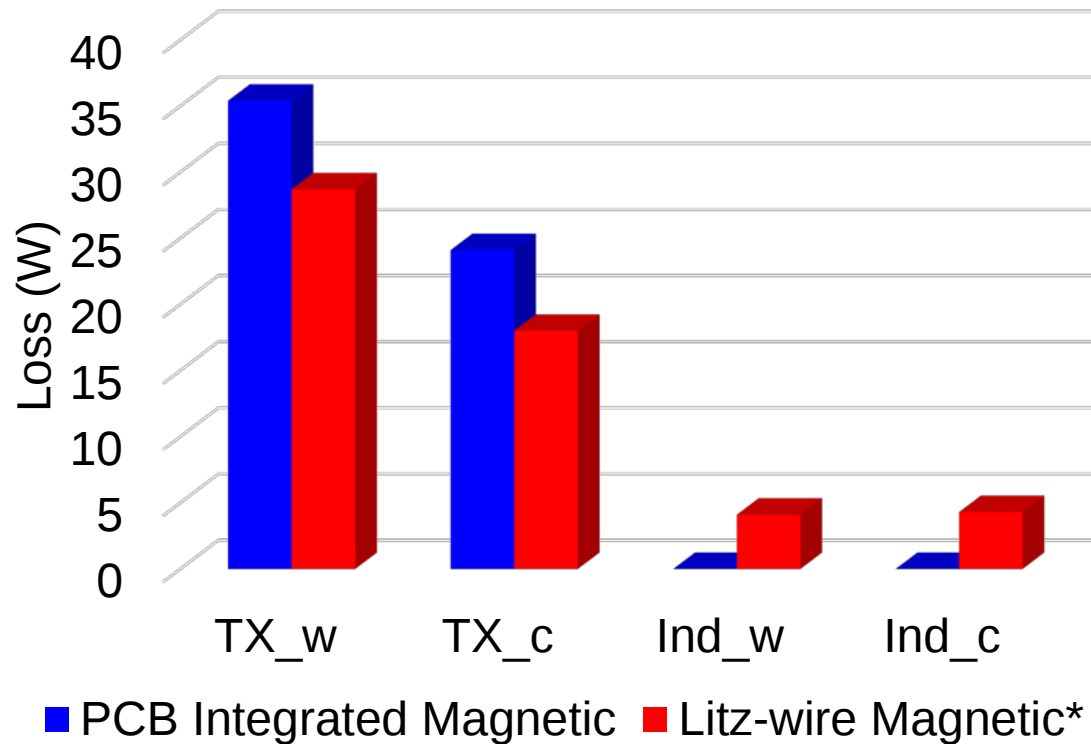
Built in Leakage Inductance



$$L_m = 17\mu\text{H} \quad L_r = 1.4\mu\text{H}$$

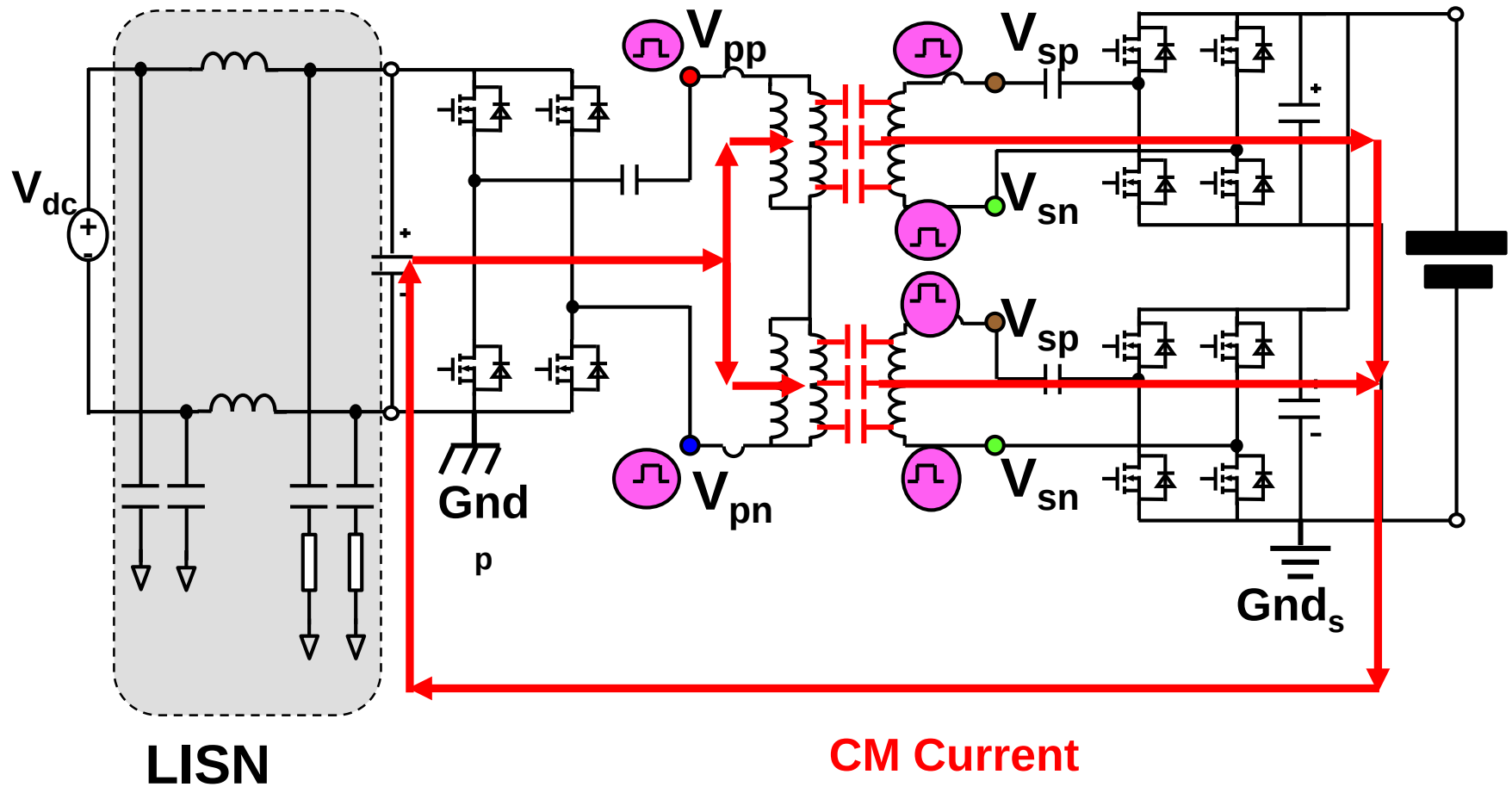
- L_m is controlled by air gap.
- L_k is controlled by center leg area.

PCB Transformer Trade off



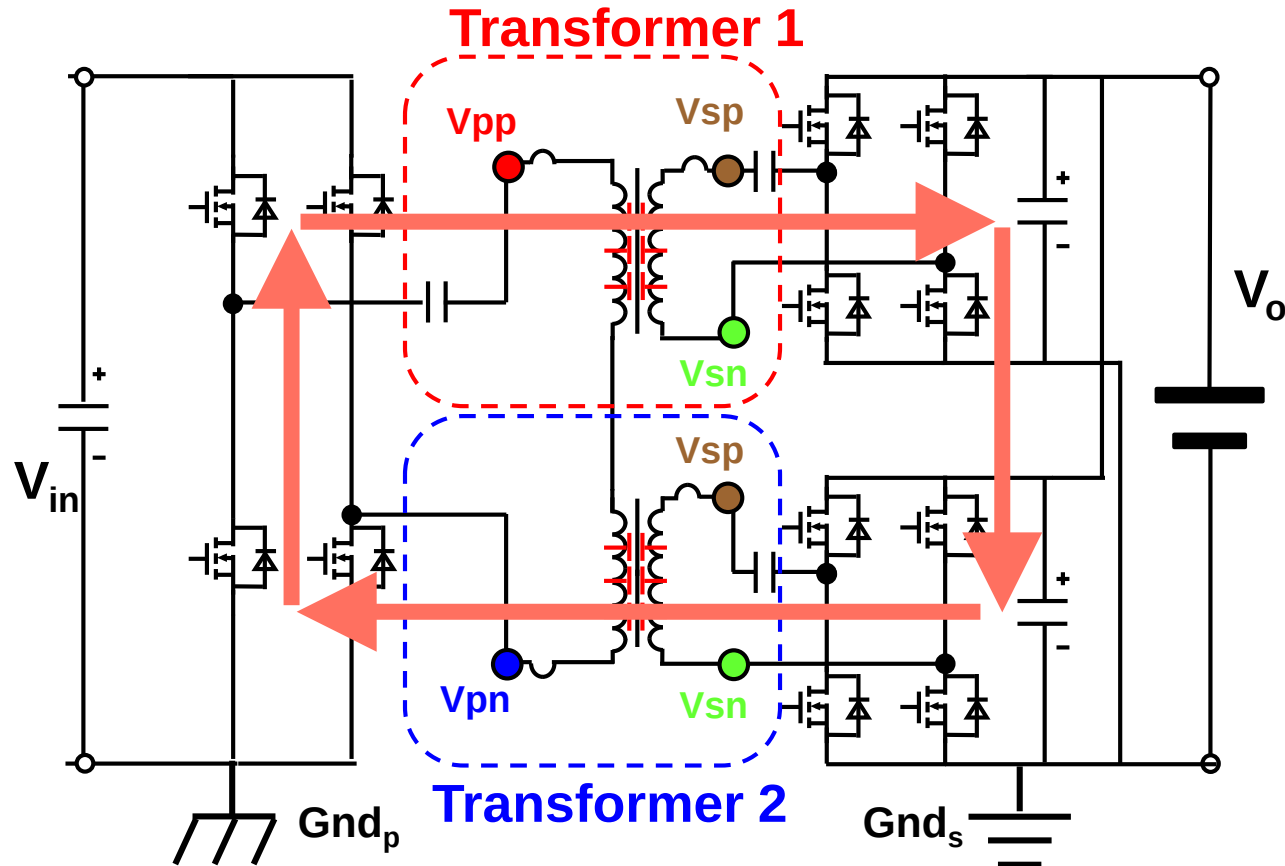
Total Loss	59.5W		55.1W
Total Volume	135cm ³		140cm ³

CM Current



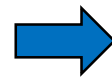
CM Noise Suppression

Using Cancellation Concept



If Tr1 and Tr2 have

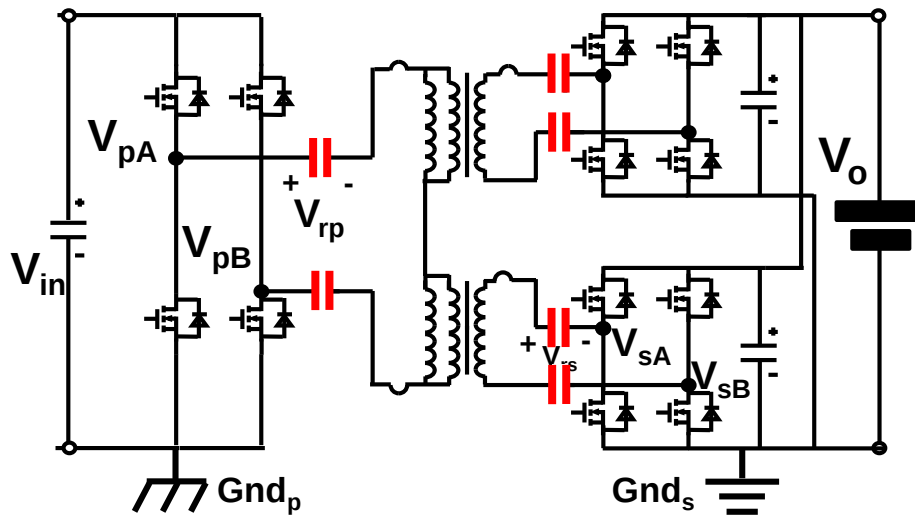
- ❖ Complimentary noise sources
- ❖ Complimentary noise path



CM current will circulate only within the two transformers

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Complimentary Noise Sources



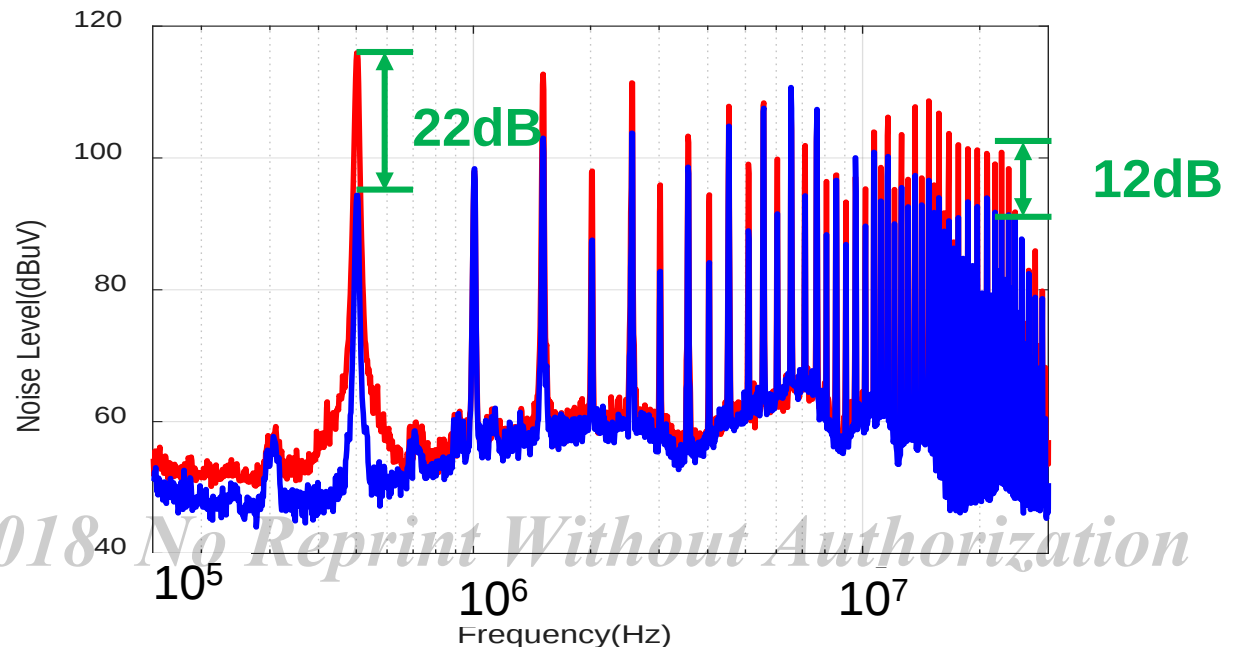
Noise sources are complimentary

Also need complimentary noise paths

Unsymm TX

Single Cap

Symm TX
Split Cap



On-Board Charger

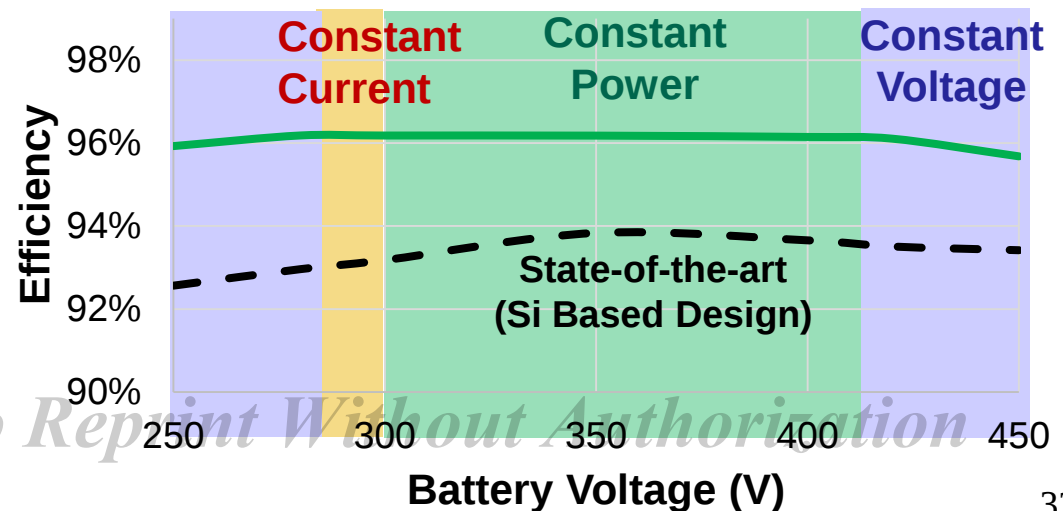


IGBT Version @ 20kHz

40% energy saving
per charging cycle



SiC/GaN; 43W/in³ **3X**



Summary

GaN to Replace Silicon

- ❖ Improvement of Efficiency (1%-2%)
- ❖ Improvement of Power Density (5X-10X)
- ❖ Improvement of EMI/EMC (20dB)
- ❖ Improvement of Manufacturability
- Paradigm shift
- ❖ Cost ???

Acknowledgement

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Dr. Xiucheng Huang
Dr Zhengyang Liu
Dr Yuchen Yang
Dr. Fei Chao
Dr Bin Li
Zhengrong Huang

Thang You

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